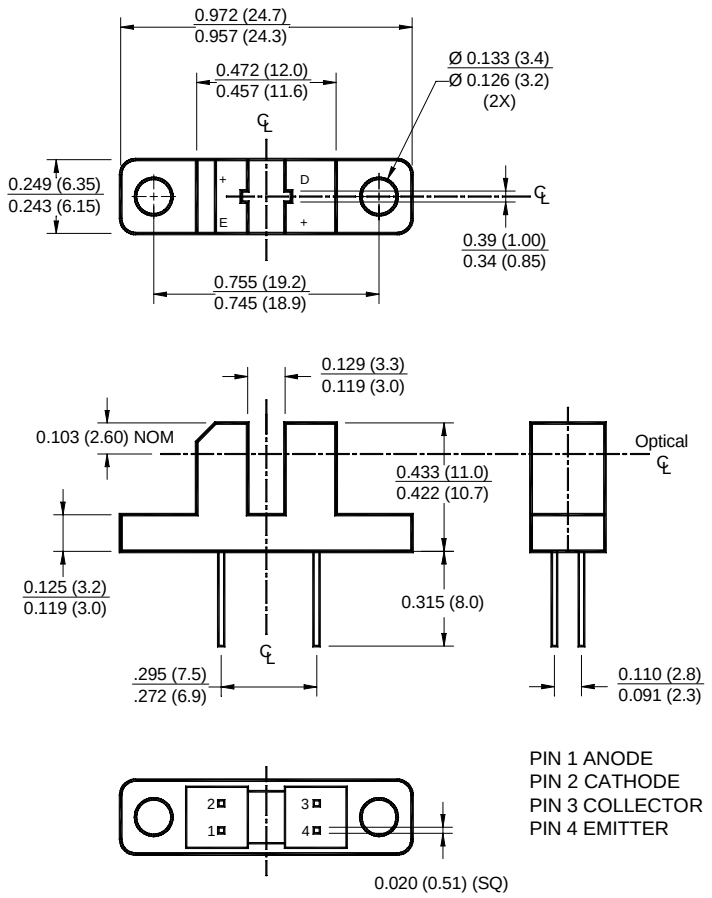
FAIRCHILD
SEMICONDUCTOR®

PHOTOTRANSISTOR OPTICAL INTERRUPTER SWITCH

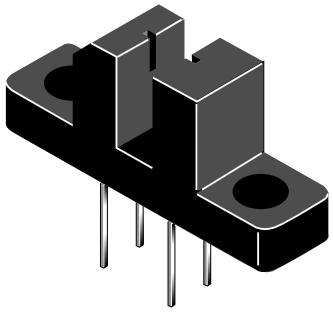
H21A4 H21A5 H21A6

PACKAGE DIMENSIONS

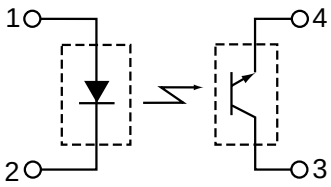


NOTES:

1. Dimensions for all drawings are in inches (mm).
2. Tolerance of ± .010 (.25) on all non-nominal dimensions unless otherwise specified.



SCHEMATIC



DESCRIPTION

The H21A series are gallium arsenide infrared emitting diode coupled with a silicon photodarlington in a plastic housing. The packaging system is designed to optimize the mechanical resolution, coupling efficiency, ambient light rejection, cost and reliability. The gap in the housing provides a means of interrupting the signal with an opaque material, switching the output from an “ON” to an “OFF” state.

FEATURES

- Opaque housing
- Low cost
- .035” apertures
- High $I_{C(ON)}$

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ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Operating Temperature	T_{OPR}	-55 to +100	°C
Storage Temperature	T_{STG}	-55 to +100	°C
Soldering Temperature (Iron)(2,3 and 4)	T_{SOL-I}	240 for 5 sec	°C
Soldering Temperature (Flow)(2 and 3)	T_{SOL-F}	260 for 10 sec	°C
INPUT (EMITTER) Continuous Forward Current	I_F	50	mA
Reverse Voltage	V_R	6	V
Power Dissipation (1)	P_D	100	mW
OUTPUT (SENSOR) Collector to Emitter Voltage	V_{CEO}	55	V
Emitter to Collector Voltage	V_{ECO}	4.5	V
Collector Current	I_C	20	mA
Power Dissipation (T_C = 25°C)(1)	P_D	150	mW

NOTE:
1. Derate power dissipation linearly 1.67 mW/°C above 25°C.
2. RMA flux is recommended.
3. Methanol or isopropyl alcohols are recommended as cleaning agents.
4. Soldering iron tip 1/16" (1.6mm) minimum from housing.

ELECTRICAL / OPTICAL CHARACTERISTICS (T_A =25°C) (All measurements made under pulse conditions)

PARAMETER	TEST CONDITIONS	SYMBOL	DEVICES	MIN	TYP	MAX	UNITS
INPUT (EMITTER) Forward Voltage	I_F = 60 mA	V_F	All	—	—	1.7	V
Reverse Breakdown Voltage	I_R = 10 µA	V_R	All	6.0	—	—	µA
Reverse Leakage Current	V_R = 3 V	I_R	All	—	—	1.0	µA
OUTPUT (SENSOR) Emitter to Collector Breakdown	I_F = 100 µA, Ee = 0	BV_{ECO}	All	6.0	—	—	V
Collector to Emitter Breakdown	I_C = 1 mA, Ee = 0	BV_{CEO}	All	55	—	—	V
Collector to Emitter Leakage	V_{CE} = 45 V, Ee = 0	I_{CEO}	All	—	—	100	nA
COUPLED On-State Collector Current	I_F = 5 mA, V_{CE} = 5 V	$I_{C(ON)}$	H21A4	0.15	—	—	mA
			H21A5	0.30	—	—	
			H21A6	0.60	—	—	
	I_F = 20 mA, V_{CE} = 5 V		H21A4	1.0	—	—	
			H21A5	2.0	—	—	
			H21A6	4.0	—	—	
	I_F = 30 mA, V_{CE} = 5 V		H21A4	1.9	—	—	
			H21A5	3.0	—	—	
			H21A6	5.5	—	—	
Saturation Voltage	I_F = 20 mA, I_C = 1.8 mA	$V_{CE(SAT)}$	H21A5/6	—	—	0.40	V
	I_F = 30 mA, I_C = 1.8 mA		H21A4	—	—	0.40	V
Turn-On Time	I_F = 30 mA, V_{CC} = 5 V, R_L = 2.5 KΩ	t_{on}	All	—	8	—	µs
Turn-Off Time	I_F = 30 mA, V_{CC} = 5 V, R_L = 2.5 KΩ	t_{off}	All	—	50	—	µs

TYPICAL PERFORMANCE CURVES

Figure 1. Output Current vs. Input Current

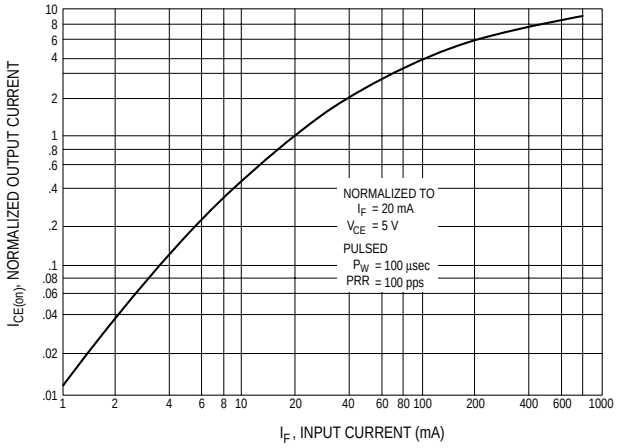


Figure 2. Output Current vs. Temperature

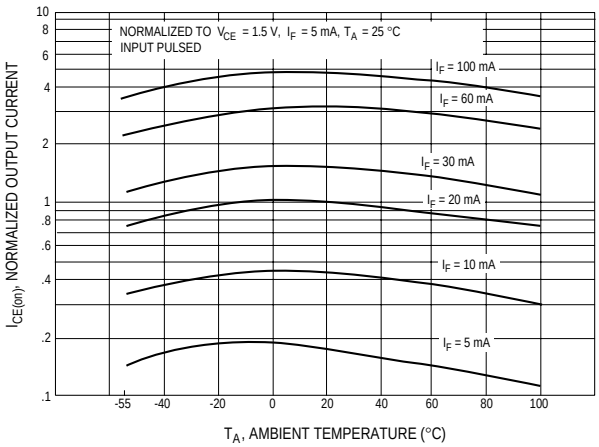


Figure 3. $V_{CE(SAT)}$ vs. Temperature

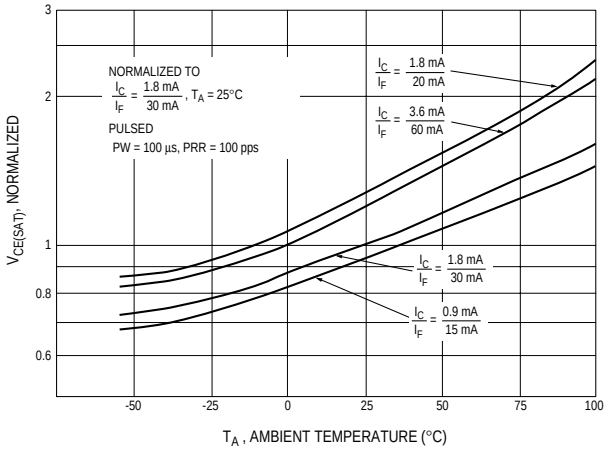


Figure 4. Leakage Current vs. Temperature

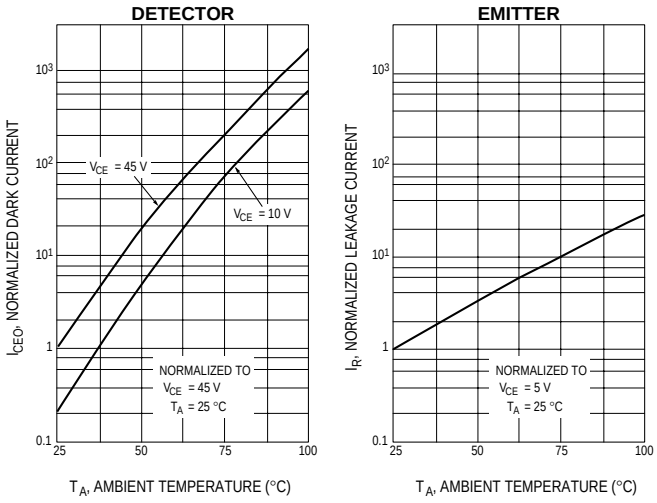


Figure 5. Switching Speed vs. RL

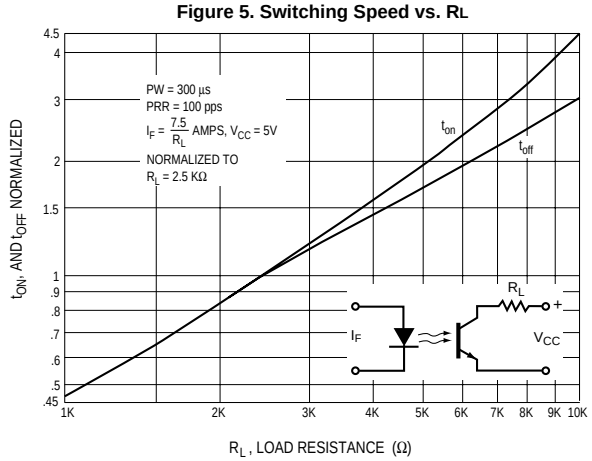
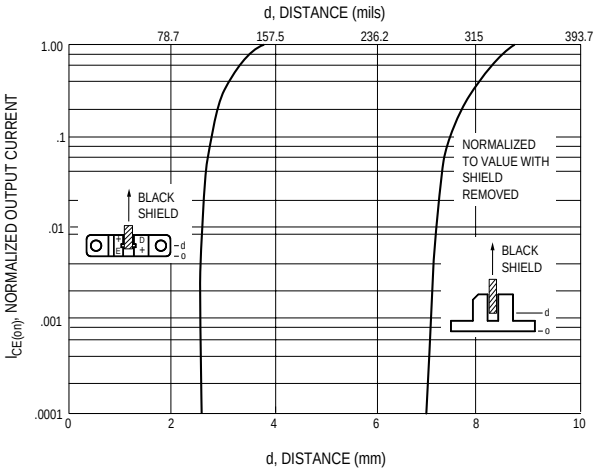


Figure 6. Output Current vs. Distance



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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.